

OxiCap® NOM Low ESR Multianodes
Niobium Oxide Capacitor



FEATURES

- Multi-anode Construction
Super Low ESR
100% Surge Current Tested
Non-Burn Safe Technology
CV Range: 220-680µF / 1.8-6.3V
IBM Global Approval Received in 2004
Elektra Award Received in 2005

APPLICATIONS

- High Power Low Voltage Industrial Power Supplies



LEAD-FREE
LEAD-FREE COMPATIBLE COMPONENT



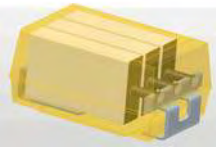
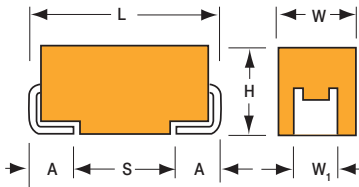
RoHS COMPLIANT



NON-BURN
NON-SMOKE



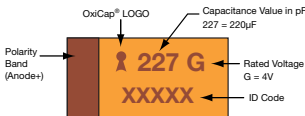
Elektra Award 2005



NOM MULTIANODE CONSTRUCTION

MARKING

E CASE



CASE DIMENSIONS:

millimeters (inches)

Table with 9 columns: Code, EIA Code, EIA Metric, L±0.20 (0.008), W+0.20 (0.008) -0.10 (0.004), H+0.20 (0.008) -0.10 (0.004), W1 ±0.20 (0.008), A+0.30 (0.012) -0.20 (0.008), S Min. Row E: 2917, 7343-43, 7.30 (0.287), 4.30 (0.169), 4.10 (0.162), 2.40 (0.094), 1.30 (0.051), 4.40 (0.173)

W1 dimension applies to the termination width for A dimensional area only.

HOW TO ORDER

NOM

Type

E

Case Size
See table above

227

Capacitance Code
1st two digits represent significant figures, 3rd digit represents multiplier in pF

M

Tolerance
M = ±20%

006

Rated DC Voltage
001 = 1.8Vdc
002 = 2.5Vdc
004 = 4Vdc
006 = 6.3Vdc

R

Packaging
R = Pure Tin 7" Reel
S = Pure Tin 13" Reel

0040

ESR in mΩ

TECHNICAL SPECIFICATIONS

Table with 2 main sections: Technical Data and Reliability. Technical Data includes Capacitance Range (220 µF to 680 µF), Tolerance (±20%), Leakage Current DCL (0.02CV), Rated Voltage DC (1.8V to 6.3V), Category Voltage (0.9V to 3V), Surge Voltage (2.3V to 5.2V), Temperature Range (-55°C to +125°C). Reliability includes 0.2% per 1000 hours at 85°C and AEC-Q200 compliance.

OxiCap® NOM Low ESR Multianodes

Niobium Oxide Capacitor



CAPACITANCE AND RATED VOLTAGE RANGE (LETTER DENOTES CASE SIZE)

Capacitance		Rated Voltage DC (V _R) to 85°C			
μF	Code	1.8V (x)	2.5V (e)	4.0V (G)	6.3V (J)
220	227				E(40)
330	337			E(35)	E(23,35)
470	477		E(30)	E(23,30)	
680	687	E(23)	E(23)		

Released ratings, (ESR ratings in mOhms in parentheses)

Note: Voltage ratings are minimum values. AVX reserves the right to supply higher voltage ratings in the same case size, to the same reliability standards.

RATINGS & PART NUMBER REFERENCE

AVX Part No.	Case Size	Capacitance (μF)	Rated Voltage (V)	Rated Temperature (°C)	Category Voltage (V)	Category Temperature (°C)	DCL Max. (μA)	DF Max. (%)	ESR Max. @ 100kHz (mΩ)	100kHz RMS Current (A)			MSL
										25°C	85°C	125°C	
1.8 Volt @ 85°C													
NOME687M001#0023	E	680	1.8	85	0.9	125	24.5	6	23	3.753	3.378	1.501	3
2.5 Volt @ 85°C													
NOME477M002#0030	E	470	2.5	85	1.3	125	23.5	10	30	3.286	2.958	1.315	3
NOME687M002#0023	E	680	2.5	85	1.3	125	34	6	23	3.753	3.378	1.501	3
4 Volt @ 85°C													
NOME337M004#0035	E	330	4	85	2	125	26.4	8	35	3.043	2.738	1.217	3
NOME477M004#0023	E	470	4	85	2	125	37.6	6	23	3.753	3.378	1.501	3
NOME477M004#0030	E	470	4	85	2	125	37.6	6	30	3.286	2.958	1.315	3
6.3 Volt @ 85°C													
NOME227M006#0040	E	220	6.3	85	3	125	26.4	12	40	2.846	2.561	1.138	3
NOME337M006#0023	E	330	6.3	85	3	125	39.6	6	23	3.753	3.378	1.501	3
NOME337M006#0035	E	330	6.3	85	3	125	39.6	6	35	3.043	2.738	1.217	3

Moisture Sensitivity Level (MSL) is defined according to J-STD-020.

All technical data relates to an ambient temperature of +25°C. Capacitance and DF are measured at 120Hz, 0.5V RMS with a maximum DC bias of 2.2 volts.

DCL is measured at rated voltage after 5 minutes.

ESR allowed to move up to 125 times catalog limit post mounting.

For typical weight and composition see page 274.

NOTE: AVX reserves the right to supply higher voltage ratings or tighter tolerance part in the same case size, to the same reliability standards.

OxiCap® NOM Low ESR Multianodes

Niobium Oxide Capacitor



QUALIFICATION TABLE

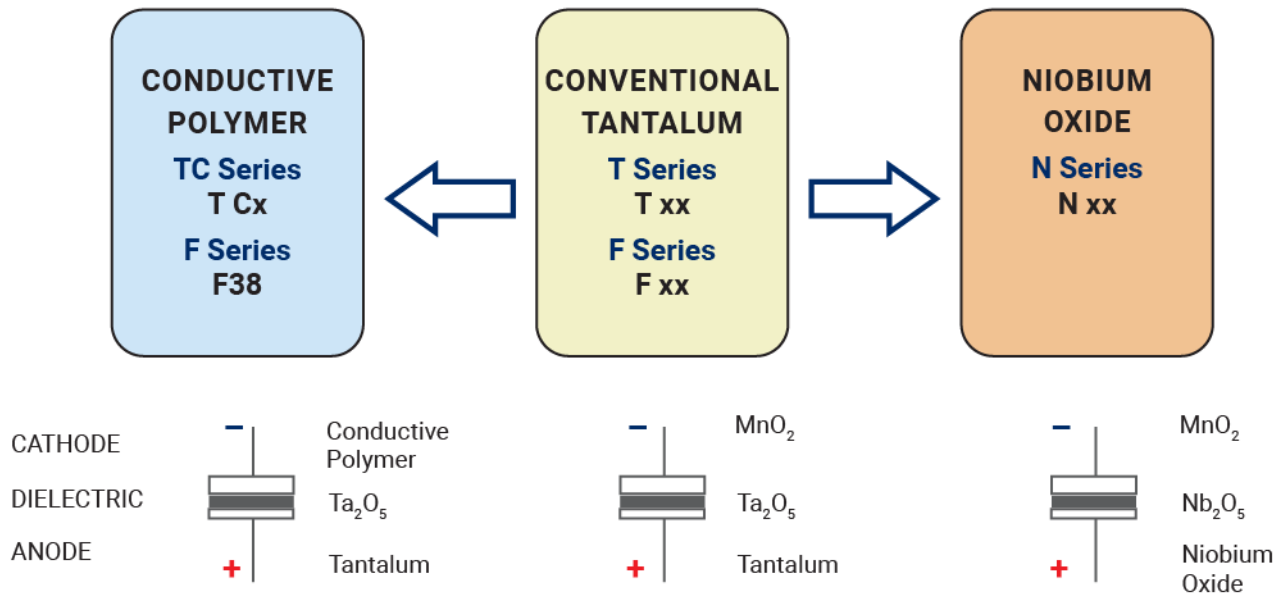
TEST	NOS series (Temperature range -55°C to +125°C)										
	Condition			Characteristics							
Endurance	Apply rated voltage (Ur) at 85°C and / or category voltage (Uc) at 125°C for 2000 hours through a circuit impedance of ≤0.1Ω/V. Stabilize at room temperature for 1-2 hours before measuring.			Visual examination	no visible damage						
				DCL	initial limit						
				ΔC/C	within ±10% of initial value						
				DF	initial limit						
				ESR	1.25 x initial limit						
Storage Life	Store at 125°C, no voltage applied, for 2000 hours. Stabilize at room temperature for 1-2 hours before measuring.			Visual examination	no visible damage						
				DCL	initial limit						
				ΔC/C	within ±10% of initial value						
				DF	initial limit						
				ESR	1.25 x initial limit						
Humidity	Store at 65°C and 95% relative humidity for 500 hours, with no applied voltage. Stabilize at room temperature and humidity for 1-2 hours before measuring.			Visual examination	no visible damage						
				DCL	1.5 x initial limit						
				ΔC/C	within ±10% of initial value						
				DF	1.2 x initial limit						
				ESR	1.25 x initial limit						
Biased Humidity	Apply rated voltage (Ur) at 85°C, 85% relative humidity for 1000 hours. Stabilize at room temperature and humidity for 1-2 hours before measuring.			Visual examination	no visible damage						
				DCL	2 x initial limit						
				ΔC/C	within ±10% of initial value						
				DF	1.2 x initial limit						
				ESR	1.25 x initial limit						
Temperature Stability	Step	Temperature°C	Duration(min)		+20°C	-55°C	+20°C	+85°C	+125°C	+20°C	
	1	+20	15								
	2	-55	15	DCL	IL*	n/a	IL*	12 x IL*	15 x IL*	IL*	
	3	+20	15	ΔC/C	n/a	+0/-10%	±5%	+10/-0%	+12/-0%	±5%	
	4	+85	15	DF	IL*	1.5 x IL*	IL*	1.5 x IL*	2 x IL*	IL*	
	5	+125	15								
	6	+20	15	ESR	1.25 x IL*	2.5 x IL*	1.25 x IL*	1.25 x IL*	1.25 x IL*	1.25 x IL*	
Surge Voltage	Apply 1.3x category voltage (Uc) at 125°C for 1000 cycles of duration 6 min (30 sec charge, 5 min 30 sec discharge) through a charge / discharge resistance of 1000Ω			Visual examination	no visible damage						
				DCL	initial limit						
				ΔC/C	within ±5% of initial value						
				DF	initial limit						
				ESR	1.25 x initial limit						
Mechanical Shock	MIL-STD-202, Method 213, Condition F			Visual examination	no visible damage						
				DCL	initial limit						
				ΔC/C	within ±5% of initial value						
				DF	initial limit						
				ESR	1.25 x initial limit						
Vibration	MIL-STD-202, Method 204, Condition D			Visual examination	no visible damage						
				DCL	initial limit						
				ΔC/C	within ±5% of initial value						
				DF	initial limit						
				ESR	1.25 x initial limit						

*Initial Limit

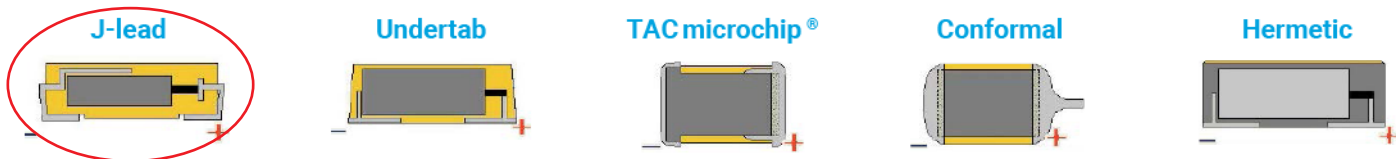
OxiCap® NOM Low ESR Multianodes
Niobium Oxide Capacitor



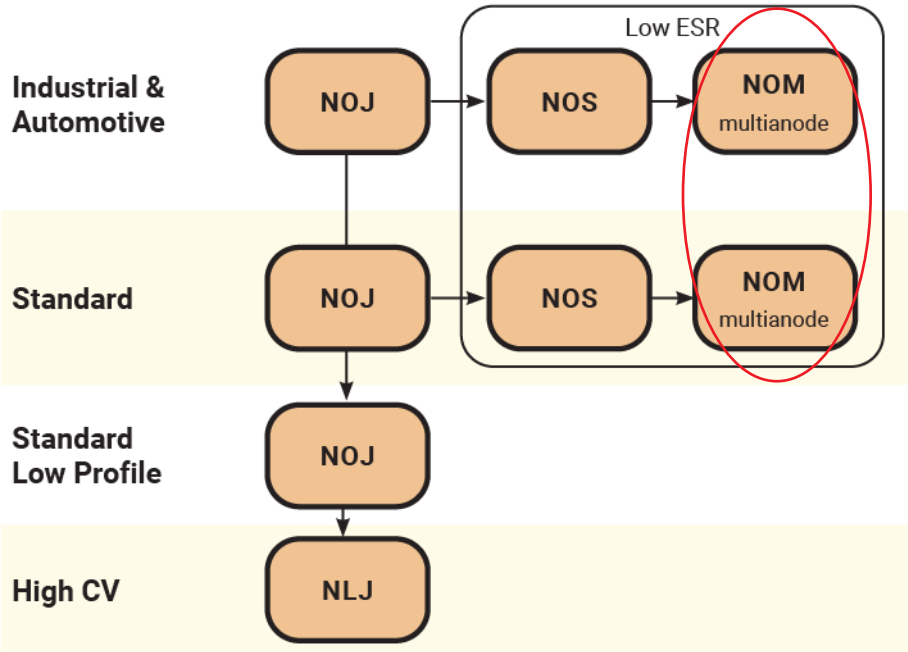
AVX SOLID ELECTROLYTIC CAPACITOR ROADMAP



FIVE CAPACITOR CONSTRUCTION STYLES



SERIES LINE UP : NIOBIUM OXIDE OxiCap® CAPACITORS



Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Kyocera AVX:

<u>NOME227M006R0040</u>	<u>NOME337M004R0035</u>	<u>NOME477M002R0030</u>	<u>NOME227M006S0040</u>	<u>NOME337M006R0023</u>
<u>NOME337M006R0035</u>	<u>NOME477M004R0023</u>	<u>NOME477M004R0030</u>	<u>NOME687M001R0023</u>	<u>NOME687M002R0023</u>
<u>NOME337M006S0023</u>	<u>NOME337M006S0035</u>			